

Search Notes

Application/Control No.

10/643,604

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under
Reexamination

NASIELSKI ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
370	259 352 353 354 355 356 357	1/30/2008	QN
455	414.1	1/30/08	QN
379	215.01	1/30/08	QN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub, USPAT, EPO, JPO	1/30/08	QN
Inventor searched in PALM	1/30/08	QN